Product data sheet

1. General description

EEPP[™]- Efficiency Enhanced Pt Planar rectifier in a 2-lead TO220 plastic package.

2. Features and benefits

- · Fast switching
- Reduces switching losses with improved lower reverse recovery charge
- · Soft recovery characteristics
- · Low thermal resistance
- · Low leakage current
- Planar termination structure
- High operating temperature capability (T_{i(max)} = 175°C)
- Higher I_{FSM} capability

3. Applications

- Switched-Mode Power Supplies
- Power factor correction diode
- Uninterrupted Power Supply

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Val	ues		Unit	
Absolute maximum rating								
V_{RRM}	repetitive peak reverse voltage		1200			V		
I _{F(AV)}	average forward current	$δ$ = 0.5; square-wave pulse; $T_{mb} \le 120$ °C; Fig. 1; Fig. 2; Fig. 3		1	5		А	
I _{FRM}	repetitive peak forward current	δ = 0.5; t _p = 25 μs; T _{mb} ≤ 120 °C; square-wave pulse	30			А		
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; <u>Fig. 4</u>	180			А		
		t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse			Α			
Symbol	Parameter	Conditions		Min	Тур	Max	Unit	
Static ch	aracteristics							
V _F	forward voltage	I _F = 15 A; T _j = 25 °C; <u>Fig. 6</u>		-	2.5	3.2	V	
		I _F = 15 A; T _j = 150 °C; <u>Fig. 6</u>		-	2.0	-	V	
Dynamic	characteristics							
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A/}\mu\text{s}$; $T_j = 25 \text{ °C}$; Fig. 7		-	45	-	ns	
Avalanche energy								
E _{AS}	non-repetitive avalanche energy	$I_R = 4 \text{ A}; L = 5 \text{ mH}; T_{j(init)} = 25 \text{ °C}$		40	-	-	mJ	

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	K	cathode	mb	K — A
2	А	anode		001aaa020
mb	mb	mounting base; connected to cathod	E A	

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
BYC15-1200P	TO220-2L	BYC15-1200PQ	Tube	50	TO220E-2L (E)	26-May-2017
					SOD59 (A)	27-Nov-2012

7. Marking

Table 4. Marking codes

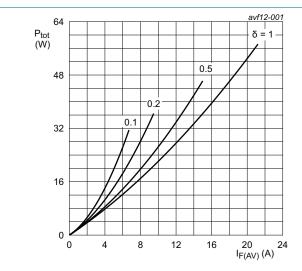
Type number	Marking codes		
	Assembly factory: E	Assembly factory: A	
BYC15-1200P	BYC15 1200P PJExxxx xx	BYC15 1200P PJAxxxx xx	

8. Limiting values

Table 5. Limiting values

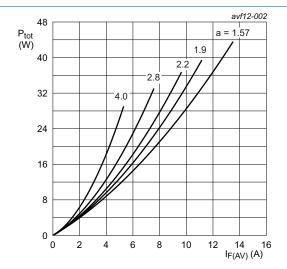
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Values	Unit
V_{RRM}	repetitive peak reverse voltage		1200	V
V_{RWM}	crest working reverse voltage		1200	V
V_R	reverse voltage	DC	1200	V
I _{F(AV)}	average forward current	$δ$ = 0.5; square-wave pulse; $T_{mb} \le 120$ °C; Fig. 1; Fig. 2; Fig. 3	15	А
I _{FRM}	repetitive peak forward current	δ = 0.5 ; t _p = 25 μs; T _{mb} ≤ 120 °C; square-wave pulse	30	А
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; Fig. 4	180	Α
		t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse	200	Α
T _{stg}	storage temperature		-65 to 175	°C
T _j	junction temperature		175	°C



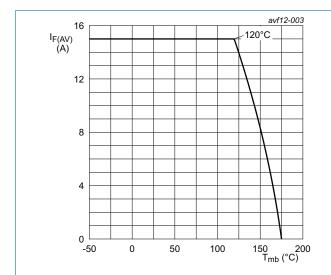
$$\begin{split} I_{F(AV)} &= I_{F(RMS)} \times \sqrt{\delta} \\ V_o &= 1.775 \text{ V; } R_s = 0.0436 \text{ } \Omega \end{split}$$

Fig. 1. Forward power dissipation as a function of average forward current; square waveform; maximum values



a = form factor = $I_{F(RMS)}/I_{F(AV)}$ V_o = 1.775 V; R_s = 0.0436 Ω

Fig. 2. Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values





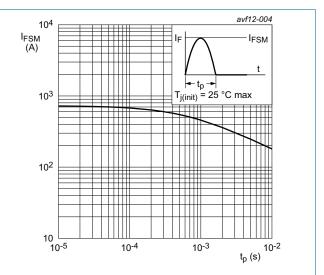


Fig. 4. Non-repetitive peak forward current as a function of pulse width; sinusoidal waveform; maximum values

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	<u>Fig. 5</u>	-	-	1.2	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	-	60	-	K/W

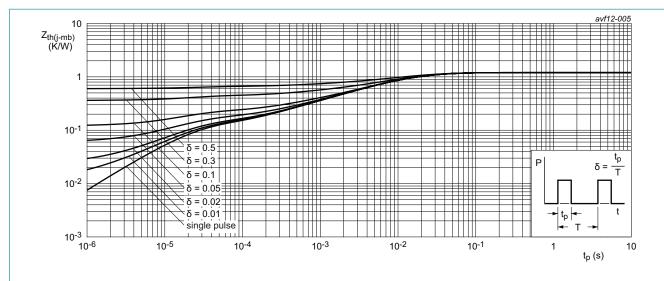


Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

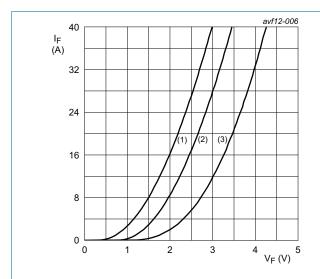
10. Characteristics

Table 7. Characteristics

Symbo	I Parameter	Conditions	Min	Тур	Max	Unit
Static c	haracteristics					
V_{F}	forward voltage	I _F = 15 A; T _j = 25 °C; <u>Fig. 6</u>	-	2.5	3.2	V
		I _F = 15 A; T _j = 150 °C; <u>Fig. 6</u>	-	2.0	-	V
I _R	reverse current	V _R = 1200 V; T _j = 25 °C	-	-	100	μA
		V _R = 1200 V; T _j = 150 °C	-	-	500	μA
Dynami	c characteristics					
Q _r	recovered charge	$I_F = 15 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A/}\mu\text{s};$ $T_j = 25 \text{ °C}; Fig. 7$	-	394	-	nC
		$I_F = 15 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 125 \text{ °C}; Fig. 7$	-	1003	-	nC
		$I_F = 15 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 150 \text{ °C}; Fig. 7$	-	1143	-	nC
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 100 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; Fig. 7$	-	45	-	ns
		$I_F = 15 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; Fig. 7$	-	61	-	ns
		$I_F = 15 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 125 \text{ °C}; Fig. 7$	-	120	-	ns
		$I_F = 15 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 150 \text{ °C}; Fig. 7$	-	128	-	ns
I _{RM}	peak reverse recovery current	$I_F = 15 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; Fig. 7$	-	12.6	-	А
		$I_F = 15 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 125 \text{ °C}; Fig. 7$	-	16.7	-	А
		$I_F = 15 \text{ A}; V_R = 400 \text{ V}; dI_F/dt = 500 \text{ A}/\mu\text{s};$ $T_j = 150 \text{ °C}; Fig. 7$	-	17.8	-	А
Avalan	che energy					
E _{AS}	non-repetitive avalanche energy	I _R = 4 A; L = 5 mH; T _{j(init)} = 25 °C	40	-	-	mJ

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 V_o = 1.775 V; R_s = 0.0436 Ω

(1) T_i = 150 °C; typical values

(2) $T_i = 150$ °C; maximum values

(3) $T_i = 25$ °C; maximum values

Fig. 6. Forward current as a function of forward voltage

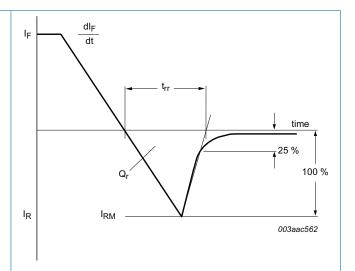
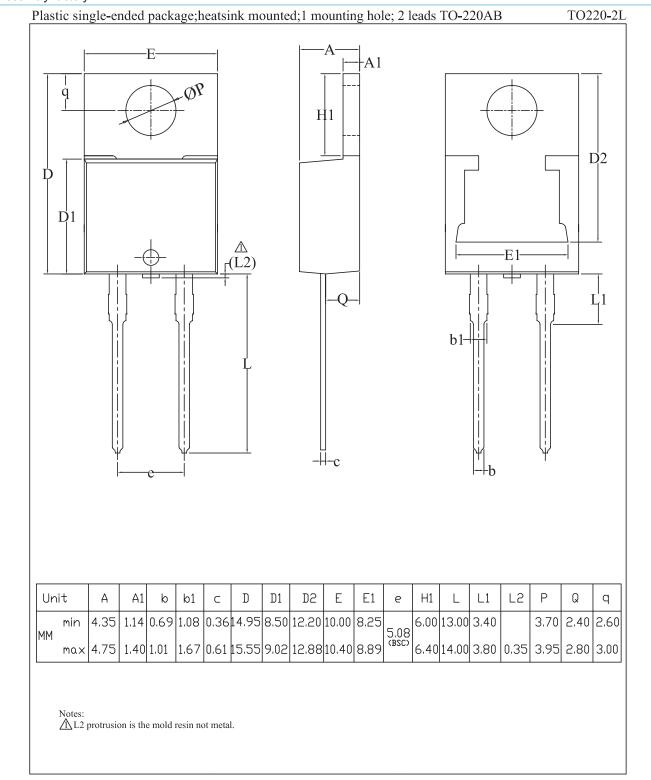


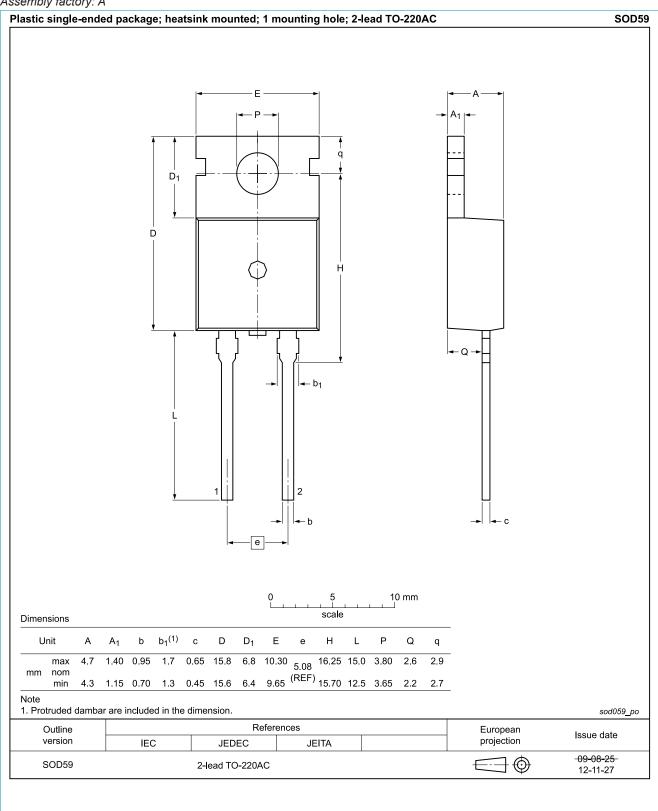
Fig. 7. Reverse recovery definitions; ramp recovery

11. Package outline

Assembly factory: E



Assembly factory: A



12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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13. Contents

1. General description	1
2. Features and benefits	1
3. Applications	1
4. Quick reference data	1
5. Pinning information	2
6. Ordering information	2
7. Marking	2
8. Limiting values	3
9. Thermal characteristics	5
10. Characteristics	6
11. Package outline	8
12. Legal information	10
13. Contents	12

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